

General Description

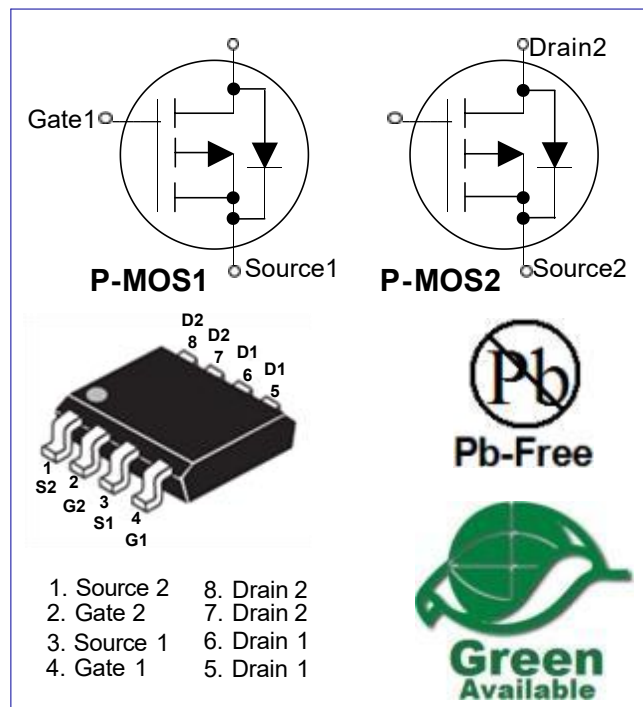
The APM4953 has dual P-channel MOSFET in one package, uses advanced trench technology to provide excellent $R_{DS(on)}$ with low gate charge. This device is suitable for use as a load switch or in PWM applications.

Features

- $V_{DS} = -20V$
- $I_D = -4.0A @ V_{GS} = -10V$
- $R_{DS(on)} = 75m\Omega (Typ.) @ V_{GS} = -10V$
- $R_{DS(on)} = 86m\Omega (Typ.) @ V_{GS} = -4.5V$
- $R_{DS(on)} = 105m\Omega (Typ.) @ V_{GS} = -2.5V$
- Advanced high cell density Trench technology
- Excellent CdV/dt effect decline
- Super Low Gate Charge
- High Power and current handing capability
- Package: SOP-8L
- Pb-Free and Green devices are available

Applications

- Load Switch
- Battery Switch
- PWM Applications
- Power Management



Ordering Information

Orderable Part Number	Package Type	Form	Minimum Order Quantity
APMAPM4953	SOP8	Tape & Reel	3000

Absolute Maximum Ratings ($T_A = 25^\circ C$ unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	-20	V
Gate-Source Voltage		V _{GS}	±10	V
Drain Current ^a	T _C = 25°C	I _D	-4.0	A
	T _C = 70°C		-2.4	
Drain Current – Pulsed ^a		I _{DM}	-16.0	A
Power Dissipation (T _C =25°C)		P _D	3.0	W
Power Dissipation (T _C =75°C)			2.0	
Storage Temperature Range		T _{STG}	-55 ~ +150	°C
Operating Junction Temperature Range		T _J	-55 ~ +150	°C
Thermal Resistance, Junction-to-Ambient (t ≤ 10s)		R _{θJA}	62.5	°C/W

Electrical Characteristics ($T_A = 25^\circ C$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = -250\mu A$	-20	---	---	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -16V, V_{GS} = 0V, T_J = 25^\circ C$	---	---	-1	μA
Gate-Body Leakage	I_{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$	---	---	± 100	nA
ON CHARACTERISTICS ^a						

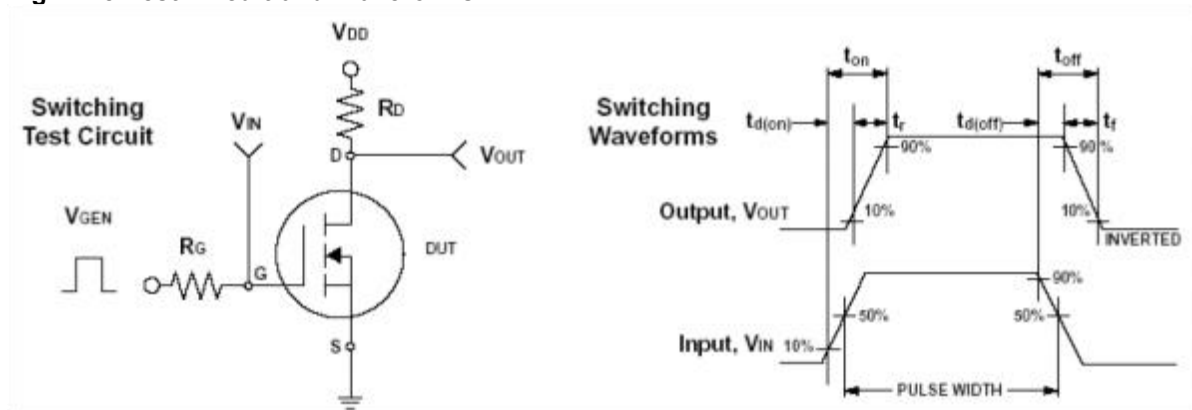
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=-250\mu A$	-0.4	-0.65	-1.0	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=-10V$, $I_D=-4.0A$	---	75	88	mΩ
	$R_{DS(on)}$	$V_{GS}=-4.5V$, $I_D=-3.0A$	---	86	105	mΩ
	$R_{DS(on)}$	$V_{GS}=-2.5V$, $I_D=-2.0A$	---	105	137	mΩ
	$R_{DS(on)}$	$V_{GS}=-1.8V$, $I_D=-1.0A$	---	135	200	mΩ
	Forward Transconductance	g_{fs}	$V_{DS}=-10V$, $I_D=-4.0A$	---	8	---
Drain-Source Diode Characteristics ^a						
Continuous Source Current	I_S	$V_G=V_D=0V$, Force Current	---	---	-4.0	A
Pulsed Source Current	I_{SM}		---	---	-16.0	A
Diode Forward Voltage	V_{SD}	$V_{GS}=0V$, $I_S=-1.0A$, $T_J=25^{\circ}C$	---	---	-1.2	V
Dynamic Characteristics ^b						
Input Capacitance	C_{iss}	$V_{DS}=-10V$, $V_{GS}=0V$, $F=1MHz$	---		---	pF
Output Capacitance	C_{oss}		---		---	pF
Reverse Transfer Capacitance	C_{rss}		---		---	pF
Switching Characteristics ^b						
Total Gate Charge	Q_g	$V_{DS}=-10V$, $V_{GS}=-4.5V$, $I_D=-4.0A$	---		---	nC
Gate-Source Charge	Q_{gs}		---		---	nC
Gate-Drain Charge	Q_{gd}		---		---	nC
Turn-On Delay Time	$T_d(on)$	$V_{DD}=-10V$, $V_{GS}=-10V$, $R_G=1\Omega$ $I_D=-1A$, $R_L=2.8\Omega$	---		---	ns
Rise Time	T_r		---		---	ns
Turn-Off Delay Time	$T_d(off)$		---		---	ns
Fall Time	T_f		---		---	ns

Notes: a. Repetitive Rating: Pulsed width limited by maximum junction temperature.

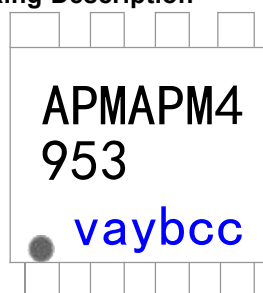
b. Pulse test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$. Essential independent of operating temperature.

c. Guaranteed by design, not subject to production testing.

Switching Time Test Circuit and Waveforms



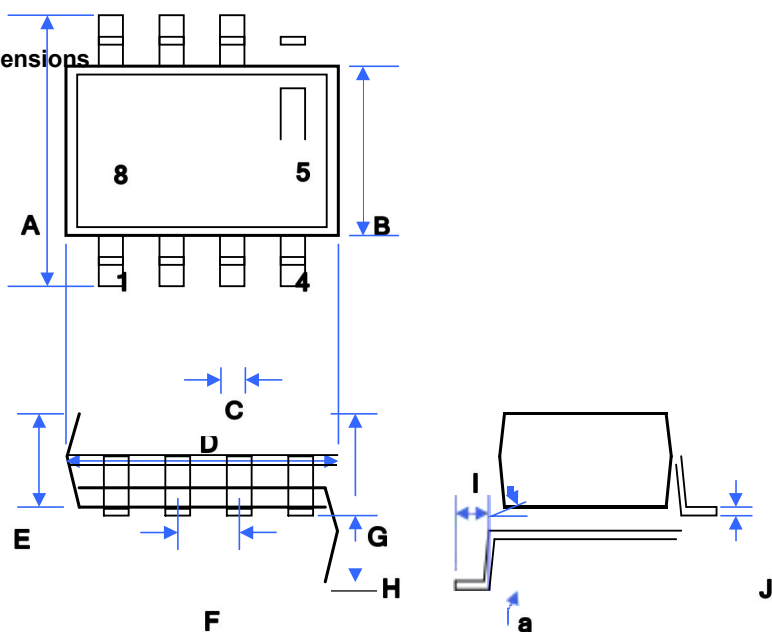
Marking Description



- --- Part Number Code
- APMAPM4953 --- Vendor Code
- v --- Assembly House Code
- a --- Year Code
- y --- Lot Code
- b --- Checking Code
- cc

Package Information

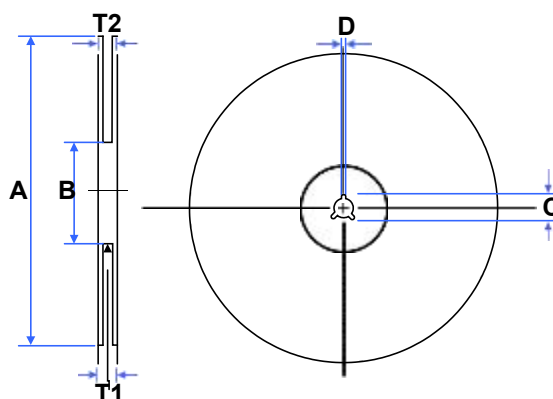
8-pin SOP Outline Dimensions



Symbol	Dimension In Millimeters (mm)		Dimension In Inches	
	Min.	Max.	Min.	Max.
A	5.800	6.300	0.228	0.248
B	3.800	4.000	0.150	0.157
C	0.330	0.510	0.013	0.020
D	4.780	5.000	0.188	0.197
E	1.350	1.550	0.053	0.061
F	1.270(Typ.)		0.050(Typ.)	
G	1.350	1.750	0.053	0.069
H	0.100	0.250	0.004	0.010
I	0.400	1.270	0.016	0.050
J	0.170	0.250	0.007	0.010
“	0°	8°	0°	8°

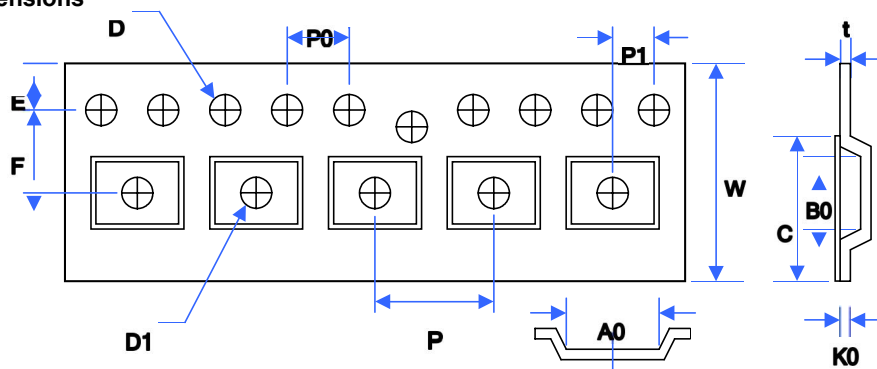
Product Tape and Reel Specifications

Reel Dimensions



Symbol	Description	SOP-8 : Dimensions in mm
A	Reel Outer Diameter	330±1.0
B	Reel Inner Diameter	62±1.5
C	Spindle Hole Diameter	13.0±0.5
D	Key Slit Width	2.0±0.15
T1	Space Between Flange	12.8±0.3
T2	Reel Thickness	12.8±0.2

Carrier Tape Dimensions



Symbol	Description	SOP-8 : Dimensions in mm
W	Carrier Tape Width	12.0±0.3
P	Cavity Pitch	8.0±0.1
E	Perforation Position	1.75±0.1
F	Cavity to Perforation (Width Direction)	5.5±0.1
D	Perforation Diameter	1.55±0.1
D1	Cavity Hole Diameter	1.5±0.25
P0	Perforation Pitch	4.0±0.1
P1	Cavity to Perforation (Length Direction)	2.0±0.1
A0	Cavity Length	6.4±0.1
B0	Cavity Width	5.20±0.1
K0	Cavity Depth	2.1±0.1
t	Carrier Tape Thickness	0.3±0.05
C	Cover Tape Width	9.3

※Unit Per Reel: 3000pcs(3K pcs)

Soldering Methods For Products

1. Storage environment : Temperature=10°C~35°C, Humidity=65%±15%
2. Reflow soldering of surface mount devices

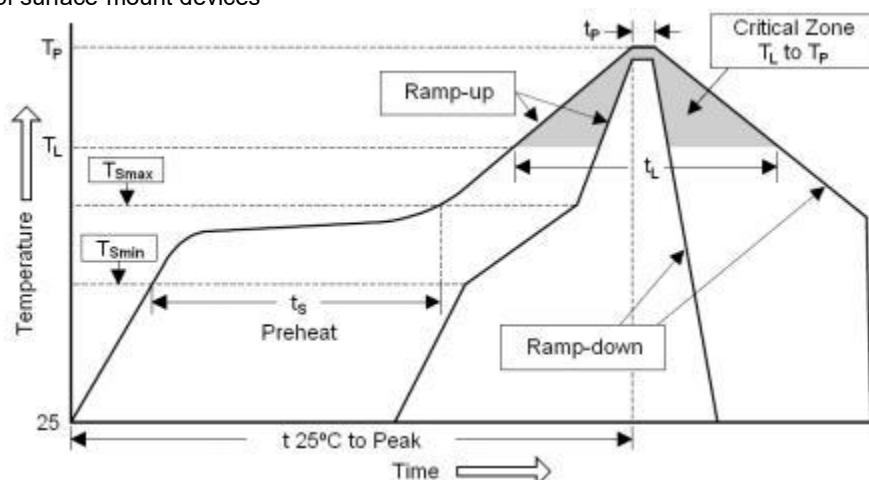


Figure : Temperature Profile

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (TL to TP)	< 3°C/sec	< 3°C/sec
Preheat		
- Temperature Min (T _{Smin})	100°C	100°C
- Temperature Max (T _{Smax})	150°C	200°C
- Time (Min to Max) (ts)	60 ~ 120 sec	60 ~ 180 sec
T _{Smax} to T _L		
- Ramp-up rate	< 3°C/sec	< 3°C/sec
Time maintained above:		
- Temperature (T _L)	183°C	217°C
- Time (t _L)	60 ~ 150 sec	60 ~ 150 sec
Peak Temperature (T _P)	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (tp)	10 ~ 30 sec	20 ~ 40 sec
Ramp-down rate	< 6°C/sec	< 6°C/sec
Time 25°C to Peak Temperature	< 6 minutes	< 8 minutes

3. Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time
Pb devices	245°C ±5°C	5sec ±1sec
Pb-Free devices	260°C +0/-5°C	5sec ±1sec

- 经锡炉或回焊炉的温度切勿超过 260 °C (Max safe temperature: 260°C)。

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- MOS 管电路是静电敏感元器件，且对生产环境要求较严，建议在存放、运输及生产操作时一定要避免静电干扰。
- 由于每个 PCB 版图和设计都不同，每个 MOSFET 的结构也不同，因此，没有通用的流程可用来计算每个应用的最大允许电流，建议在选用 MOS 管器件时考虑到余量，以免 MOS 管因此而造成损坏。